

4-Channel ESD/EMI Filter Array plus 4-Channel ESD Array for USB

Features

- Four channels of combined EMI/RFI filtering + ESD protection
- Four additional channels of ESD-only protection
- EMI/ESD channels provide greater than 32dB attenuation at 1GHz
- ±15kV ESD protection on all channels (IEC 61000-4-2 Level 4, contact discharge)
- ± 30kV ESD protection on all channels (HBM)
- Chip Scale Package features extremely low lead inductance for optimum filter and ESD performance
- 15-bump, 2.960mm X 1.330mm footprint Chip Scale Package (CSP)
- · Lead-free version available

Applications

- EMI filtering and ESD protection for both data and I/O ports
- Outer 4 channels provide ESD protection for USB lines and other I/O port applications
- Wireless Handsets
- Handheld PCs / PDAs
- MP3 Players
- Notebooks
- Desktop PCs

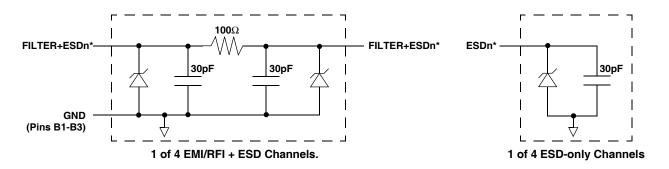
Product Description

The CSPEMI307A is a multichannel EMI/ESD array offering a combination of four low-pass filter + ESD channels to reduce EMI/RFI emissions on a data port and four dedicated ESD-only channels intended specifically for ESD protection on a USB port. Each EMI/RFI channel integrates a high quality pi-style filter (C-R-C) which provides greater than 30dB attenuation in the 800-2700 MHz range. These pi-style filters support bidirectional filtering, controlling EMI both to and from a data port connector.

The CSPEMI307A provides a high-level of ESD protection on all eight channels for sensitive electronic components that may be subjected to electrostatic discharge (ESD). The input pins are designed and characterized to safely dissipate ESD strikes of ±15kV, exceeding the maximum requirement of the IEC 61000-4-2 international standard. Using the MIL-STD-883 (Method 3015) specification for Human Body Model (HBM) ESD, the device provides protection for contact discharges to greater than ±30kV.

The CSPEMI307A is particularly well suited for portable electronics (e.g., cellular telephones, PDAs, notebook computers) because of its small package footprint and low weight. The CSPEMI307A is available in a space-saving, low-profile Chip Scale Package with optional lead-free finishing.

Electrical Schematic



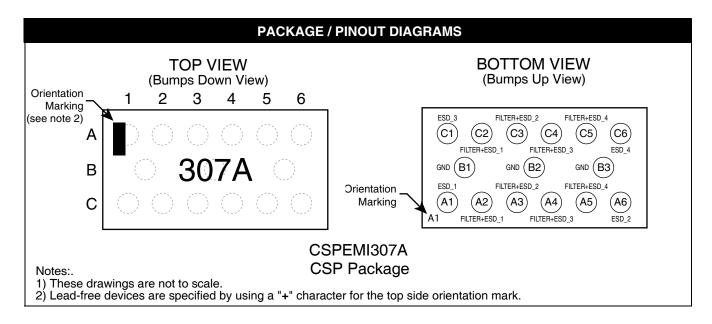
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1

^{*} See Package/Pinout Diagram for expanded pin information





	PIN DESCRIPTIONS					
PIN(s)	NAME	DESCRIPTION				
A1	ESD_1	ESD Channel 1				
A2	FILTER+ESD_1	Filter + ESD Channel 1				
А3	FILTER+ESD_2	Filter + ESD Channel 2				
A4	FILTER+ESD_3	Filter + ESD Channel 3				
A 5	FILTER+ESD_4	Filter + ESD Channel 4				
A6	ESD_2	ESD Channel 2				
B1-B3	GND	Device Ground				
C1	ESD_3	ESD Channel 3				
C2	FILTER+ESD_1	Filter + ESD Channel 1				
C3	FILTER+ESD_2	Filter + ESD Channel 2				
C4	FILTER+ESD_3	Filter + ESD Channel 3				
C 5	FILTER+ESD_4	Filter + ESD Channel 4				
C6	ESD_4	ESD Channel 4				

Ordering Information

PART NUMBERING INFORMATION							
		Standa	rd Finish	Lead-free Finish ²			
Bumps	Package	Ordering Part Number ¹	Part Marking	Ordering Part Number ¹	Part Marking		
Dullips	rackage	Number	rait Waiking	Number	Fait Marking		
15	CSP	CSPEMI307A	307A	CSPEMI307AG	307A		

Note 1: Parts are shipped in Tape & Reel form unless otherwise specified.

Note 2: Lead-free devices are specified by using a "+" character for the top side orientation mark.



Specifications

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	RATING	UNITS			
Storage Temperature Range	-65 to +150	°C			
DC Power per Resistor	100	mW			
DC Package Power Rating	600	mW			

STANDARD OPERATING CONDITIONS						
PARAMETER	RATING	UNITS				
Operating Temperature Range	-40 to +85	°C				

	ELECTRICAL O	PERATING CHARA	CTERI	STICS	1	
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
R	Resistance		80	100	120	Ω
С	Capacitance	At 2.5V DC	24	30	36	pF
TCR	Temperature Coefficient of Resistance			1200		ppm/°C
TCC	Temperature Coefficient of Capacitance	At 2.5V DC		-300		ppm/°C
V _{DIODE}	Diode Voltage (reverse bias)	I _{DIODE} =10μA	5.5			V
I _{LEAK}	Diode Leakage Current (reverse bias)	V _{DIODE} =3.3V			100	nA
V _{SIG}	Signal Voltage Positive Clamp Negative Clamp	I _{LOAD} = 10mA	5.6 -0.4	6.8 -0.8	9.0 -1.5	V V
V _{ESD}	In-system ESD Withstand Voltage a) Human Body Model, MIL-STD-883, Method 3015 b) Contact Discharge per IEC 61000-4-2 Level 4	Notes 2,4 and 5	±30 ±15			kV kV
V _{CL}	Clamping Voltage during ESD Discharge MIL-STD-883 (Method 3015), 8kV Positive Transients Negative Transients	Notes 2,3,4 and 5		+10 - 5		V V
f _C	Cut-off frequency $Z_{SOURCE} = 50\Omega$, $Z_{LOAD} = 50\Omega$	R = 100Ω, C = 30pF		64		MHz

Note 1: $T_A=25$ °C unless otherwise specified.

Note 2: ESD applied to input and output pins with respect to GND, one at a time.

Note 3: Clamping voltage is measured at the opposite side of the EMI filter to the ESD pin. For example, if ESD is applied to Pin A2, then clamping voltage is measured at Pin C2.

Note 4: Unused pins are left open

Note 5: These parameters are guaranteed by design and characterization.



Performance Information

Typical Filter Performance (T_A=25°C, DC Bias=0V, 50 Ohm Environment)

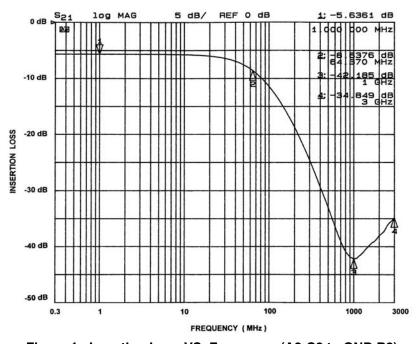


Figure 1. Insertion Loss VS. Frequency (A2-C2 to GND B2)

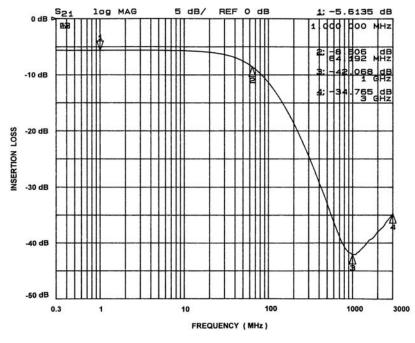


Figure 2. Insertion Loss VS. Frequency (A3-C3 to GND B2)



Performance Information

Typical Filter Performance (T_A=25°C, DC Bias=0V, 50 Ohm Environment)

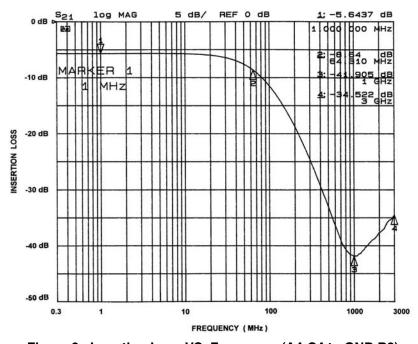


Figure 3. Insertion Loss VS. Frequency (A4-C4 to GND B2)

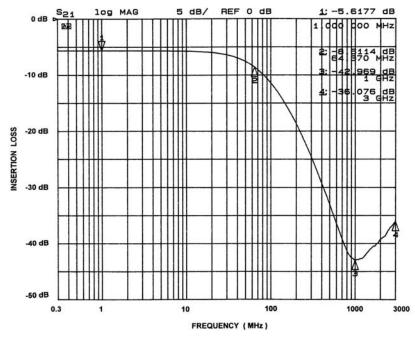


Figure 4. Insertion Loss VS. Frequency (A5-C5 to GND B2)

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Performance Information

Typical Filter Performance (T_A=25°C, 50 Ohm Environment)

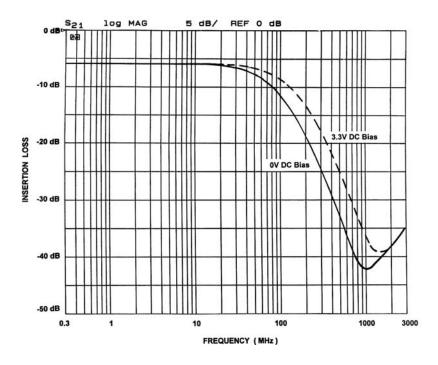


Figure 5. Comparison of Filter Response Curves for CSPEMI307A VS. DC Bias



Performance Information (cont'd)

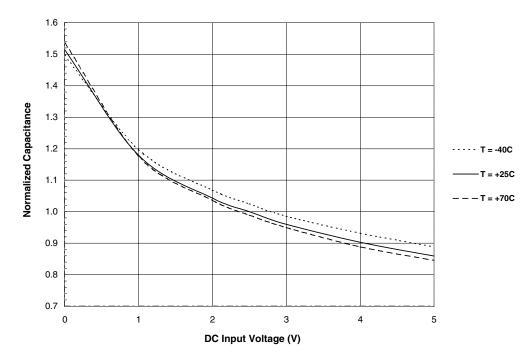


Figure 6. Filter Capacitance vs. Input Voltage over Temperature (normalized to capacitance at 2.5VDC and 25°C)

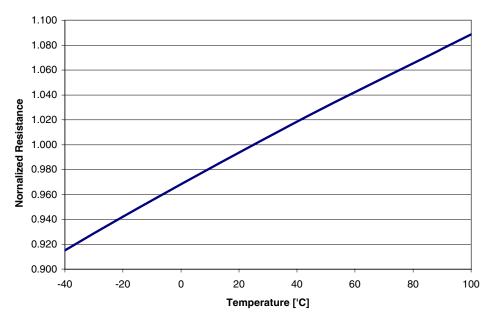


Figure 7. Resistance vs. Temperature (normalized to resistance at 25°C)



Application Information

Refer to Application Note AP-217, "The Chip Scale Package", for a detailed description of Chip Scale Packages offered by California Micro Devices.

PRINTED CIRCUIT BOARD RECOMMENDATIONS						
PARAMETER	VALUE					
Pad Size on PCB	0.275mm					
Pad Shape	Round					
Pad Definition	Non-Solder Mask defined pads					
Solder Mask Opening	0.325mm Round					
Solder Stencil Thickness	0.125 - 0.150mm					
Solder Stencil Aperture Opening (laser cut, 5% tapered walls)	0.330mm Round					
Solder Flux Ratio	50/50 by volume					
Solder Paste Type	No Clean					
Pad Protective Finish	OSP (Entek Cu Plus 106A)					
Tolerance — Edge To Corner Ball	<u>+</u> 50μm					
Solder Ball Side Coplanarity	<u>+</u> 20μm					
Maximum Dwell Time Above Liquidous	60 seconds					
Maximum Soldering Temperature for Eutectic Devices using Eutectic Solder Paste	240°C					
Maximum Soldering Temperature for Lead-free Devices using Lead-free Solder Paste	260°C					

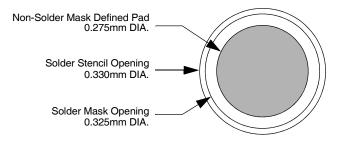


Figure 8. Recommended Non-Solder Mask Defined Pad Illustration

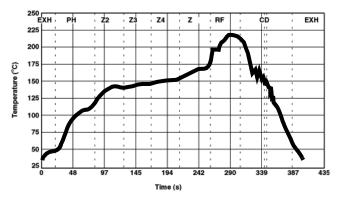


Figure 9. Eutectic (SnPb) Solder **Ball Reflow Profile**

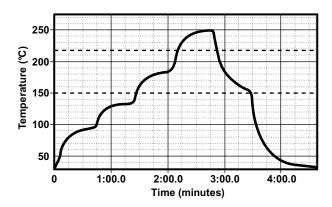


Figure 10. Lead-free (SnAgCu) Solder **Ball Reflow Profile**

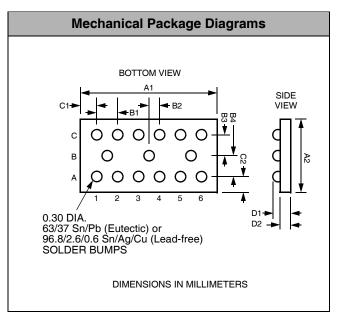


Mechanical Details

CSP Mechanical Specifications

The CSPEMI307A is offered in a custom Chip Scale Package (CSP). Dimensions are presented below. For complete information on the CSP, see the California Micro Devices CSP Package Information document.

PACKAGE DIMENSIONS							
Package		Custom CSP					
Bumps		15					
Dim	M	lillimete	rs	Inches			
Dilli	Min	Nom	Max	Min	Nom	Max	
A1	2.915	2.960	3.005	0.1148	0.1165	0.1183	
A2	1.285	1.330	1.375	0.0506	0.0524	0.0541	
B1	0.495	0.500	0.505	0.0195	0.0197	0.0199	
B2	0.245	0.250	0.255	0.0096	0.0098	0.0100	
В3	0.430	0.435	0.440	.440 0.0169		0.0173	
B4	0.430	0.435	0.440	0.0169	0.0171	0.0173	
C1	0.180	0.230	0.280	0.280 0.0071 0.0091 0.0			
C2	0.180	0.230	0.280	0.0071 0.0091 0		0.0110	
D1	0.561	0.605	0.649	0.0221	0.0238	0.0256	
D2	0.355	0.380	0.405	0.0140	0.0150	0.0160	
# per tape and reel		3500 pieces					
Controlling dimension: millimeters							



Package Dimensions for CSPEMI307A Chip Scale Package

CSP Tape and Reel Specifications

PART NUMBER	CHIP SIZE (mm)	POCKET SIZE (mm) B ₀ X A ₀ X K ₀	TAPE WIDTH W	REEL DIAMETER	QTY PER REEL	P_0	P ₁
CSPEMI307A	2.96 X 1.33 X 0.605	3.10 X 1.45 X 0.74	8mm	178mm (7")	3500	4mm	4mm

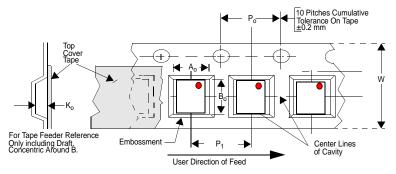


Figure 11. Tape and Reel Mechanical Data

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